

# Critical current for field-free switching of the in-plane magnetization in the three-terminal magnetic tunnel junction

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## Appendix A Details for theoretical derivation of the TST device

The Routh-Hurwitz criterion is a mathematical method used to determine the stability of a linear time-invariant (LTI) system by analyzing the roots distribution of their characteristic polynomial in the complex plane. Specifically, it checks whether all roots lie in the left half-plane (LHP), ensuring system stability, without explicitly solving for the roots. This method has been widely applied in various research fields, such as magnetodynamic [1], circuit stability assessment [2], and epidemiological disease spread prediction [3].

Based on the above criterion and LLG equation, two equilibriums  $\vec{m} = (1, 0, 0)$  and  $\vec{m} = (-1, 0, 0)$  are derived by setting  $\partial m_{x,y,z}/\partial t = 0$

$$H_d m_y m_z + H_{\text{SOT}} m_x m_y - H_{\text{STT}}(m_y^2 + m_z^2) = 0, \quad (\text{A1})$$

$$-(H_d + H_k) m_x m_z - H_{\text{SOT}}(m_x^2 + m_z^2) + H_{\text{STT}} m_x m_y = 0, \quad (\text{A2})$$

$$H_k m_x m_y + H_{\text{SOT}} m_y m_z + H_{\text{STT}} m_x m_z = 0, \quad (\text{A3})$$

For the first formula, considering  $m_y$  and  $m_z$  are quite small, and  $H_d$  is much larger than  $H_{\text{STT}}$ , so Eq. (A1) can be rewritten as follows:

$$H_d m_y m_z + H_{\text{SOT}} m_x m_y = 0, \quad (\text{A4})$$

By combining Eq. (A3) and Eq. (A4), two equilibrium solutions are obtained, as:

$$E = \pm \left( m_x, \frac{H_{\text{STT}} H_{\text{SOT}} m_x}{H_d H_k - H_{\text{SOT}}^2}, -\frac{H_{\text{SOT}} m_x}{H_d} \right), \quad (\text{A5})$$

Next, by decoupling LLG equation, formulas for magnetization components along the  $x$ ,  $y$ , and  $z$  directions are derived as:

$$\begin{cases} f_x = \frac{\gamma}{(1 + \alpha^2)} \{ \alpha [H_k m_x (m_y^2 + m_z^2) + H_{\text{SOT}} m_z + H_d m_x m_z^2] - H_{\text{STT}}(m_y^2 + m_z^2) + H_{\text{SOT}} m_x m_y + H_d m_y m_z \}, \\ f_y = \frac{-\gamma}{(1 + \alpha^2)} [\alpha (H_{\text{STT}} m_z + H_k m_x^2 m_y - H_d m_y m_z^2) + H_{\text{SOT}}(m_x^2 + m_z^2) + H_k m_x m_z - H_{\text{STT}} m_x m_y + H_d m_x m_z], \\ f_z = \frac{-\gamma}{(1 + \alpha^2)} [\alpha (H_{\text{SOT}} m_x - H_{\text{STT}} m_y + H_k m_x^2 m_z + H_d m_x^2 m_z + H_d m_y^2 m_z) \\ - H_{\text{SOT}} m_y m_z - H_k m_x m_y - H_{\text{STT}} m_x m_z], \end{cases} \quad (\text{A6})$$

The characteristic polynomial of the Jacobian matrix is written as:

$$P = a_0 \lambda^3 + a_1 \lambda^2 + a_2 \lambda + a_3, \quad (\text{A7})$$

According to Routh-Hurwitz criterion, the critical condition for reaching equilibrium is that  $\Delta_1, \Delta_2 > 0$ ,  $a_0 > 0$  or when  $\Delta_1, \Delta_2 < 0$ ,  $a_0 < 0$ . Here,  $\Delta_1$  and  $\Delta_2$  are given by:

$$\Delta_1 = a_1 = \frac{\gamma}{1 + \alpha^2} [\alpha H_k (1 - 3m_x^2) + \alpha H_d (3m_z^2 - 1) + 2H_{\text{SOT}} m_y + 2H_{\text{STT}} m_x], \quad (\text{A8})$$

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$$\Delta_2 = \left\| \begin{pmatrix} a_1 & a_0 \\ a_3 & a_2 \end{pmatrix} \right\|, \quad (\text{A9})$$

From the Jacobian matrix, it is easy to infer that  $a_0 < 0$  in this case. Consequently, the equilibrium may become unstable under the condition  $\Delta_1 > 0$ , leading to magnetization switching. By substituting Eq. (A5) into  $\Delta_1 > 0$  and considering  $m_x \sim +1$ , the switching condition can be derived as:

$$H_{\text{STT}} > \alpha \left( 1 - \frac{H_{\text{SOT}}^2}{H_d H_k} \right) \left( H_k + \frac{H_d^2 - 3H_{\text{SOT}}^2}{2H_d} \right), \quad (\text{A10})$$

Finally, by incorporating both  $H_{\text{STT}}$  and  $H_{\text{SOT}}$ :

$$H_{\text{STT}} = \frac{\hbar P J_{\text{STT}}}{2et_F M_s}, H_{\text{SOT}} = \frac{\hbar \theta_{\text{SHE}} J_{\text{SOT}}}{2et_F M_s}, \quad (\text{A11})$$

the critical switching current density for STT in the assistance of SOT is obtained as:

$$J_{\text{STT,c}} = \frac{2\alpha et_F M_s}{\hbar P} \left( 1 - \frac{H_{\text{SOT}}^2}{H_d H_k} \right) \left( H_k + \frac{H_d^2 - 3H_{\text{SOT}}^2}{2H_d} \right), \quad (\text{A12})$$

This formula is consistent with Eq. (3) in the main text, demonstrating an inverse correlation between  $J_{\text{STT,c}}$  and  $J_{\text{SOT}}$ . The relationship has been experimentally corroborated [4, 5], confirming the validity of our model.

## Appendix B Details for theoretical derivation of the canted Type-x device

Extending the above approach to the canted Type-x device, LLG equation can be further modified as:

$$\frac{\partial \vec{m}}{\partial t} = -\gamma \vec{m} \times \vec{H}_{\text{eff}} + \alpha \vec{m} \times \frac{\partial \vec{m}}{\partial t} - \gamma H_{\text{SOT}} \vec{m} \times (\vec{\sigma} \times \vec{m}), \quad (\text{B1})$$

When the applied SOT current is canted from easy-axis, the spin polarization  $\vec{\sigma}$  can be expressed as  $(\sin \varphi, \cos \varphi, 0)$ , where  $\varphi$  represents the canted angle, as shown in Figure 1(e) of the main text. Following the above approach, we get the formula of SOT critical switching current density:

$$J_{\text{SOT,c}} = \frac{et_F M_s}{\hbar \theta_{\text{SHE}}} \frac{2H_d H_k \sin \varphi}{\alpha (2H_k + H_d) \cos^2 \varphi} \times \left[ \sqrt{1 + \frac{\alpha^2 (2H_k + H_d)^2 \cos^2 \varphi}{H_d H_k \sin^2 \varphi}} - 1 \right], \quad (\text{B2})$$

which is equivalent to Eq. (4) in the main text.

When considering the field-like torque (FLT), SOT is composed of two parts: damping-like torque (DLT)  $\vec{\tau}_{\text{DLT}} \propto \vec{m} \times (\vec{\sigma} \times \vec{m})$  and FLT  $\vec{\tau}_{\text{FLT}} \propto \vec{m} \times \vec{\sigma}$ . In the Type-x device, the  $y$ -aligned spin-polarized current generates DLT, which drives magnetization to rotate towards the  $z$ -axis. The FLT exhibits characteristics of an in-plane bias field oriented along the hard-axis ( $y$ -direction), thus inducing magnetization deviation from equilibrium configuration while simultaneously reducing the energy barrier, contributing to the decrease in the switching current density [6]. However, in the case of large FLT/DLT ratio, FLT can also introduce additional degrees of freedom, leading to non-deterministic switching [7]. Therefore, the critical switching current cannot be well defined due to the oscillatory switching behavior.

## Appendix C Details of simulation parameters

Main parameters in both macorspin and micromagnetic simulations are configured as follows:  $\alpha = 0.033$ ,  $M_s = 1000$  emu/cm<sup>3</sup>,  $\theta_{\text{SHE}} = 0.3$  and  $P = 0.6$ . These values are basically consistent with the experimental measurements and simulation setups [8–10]. The initial magnetization state is defined as  $m_x \sim +1$ , and the complete switching is defined as  $m_x \sim -0.9$  within 3  $\mu$ s. The MTJ has an elliptical shape with a free layer thickness of 1.4 nm, and the aspect ratio is 2.

For macorspin simulations, RK4 algorithm with a step of  $10^{-11}$  s is adopted. Micromagnetic simulations are performed using the Object Oriented MicroMagnetic Framework (OOMMF) [11] and the exchange constant  $A = 1.6 \times 10^{-11}$  J/m. Magnetic anisotropy is determined by saturation magnetization and the aspect ratio of the elliptical shape, which is calculated intrinsically by OOMMF. The mesh size is  $2 \times 2 \times 1.4$  nm<sup>3</sup>. For updating the magnetization configuration, we choose “Oxs\_SpinXferEvolve” with a step size equal to 0.01 for the first candidate iteration and the *rk4* method for Runge-Kutta implementation. Before the current is applied, the magnetization is set to relax for 1 ns. In addition, we set the stop-time of 3  $\mu$ s in “Oxs\_TimeDriver”. All simulations are performed at zero temperature as the effect of thermal noise is not the focus of this work.

## Appendix D Further analysis of the canted Type-x device

In the main text, Figure 1(f) illustrates the dependence of  $J_{\text{SOT,c}}$  on the canted angle  $\varphi$ . The relationship between  $J_{\text{SOT,c}}$  and  $\varphi$  follows an approximate proportion to  $1/\sin \varphi$ . The insets provide further details on magnetization dynamics under both critical and supercritical current conditions. As  $\varphi$  increases, the current required for switching decreases. Notably,

the precession trajectory is shortened, indicating an accelerated switching response. Figure 1(g) shows the relative errors of Eq. (4) for different free layer dimensions. When the length of the main axis is less than 120 nm, the relative error remains within 1.25%. However, as the length increases to 160 nm, the relative error grows. This increase can arise from magnetic nucleation effects.

Further validation is conducted with the pulse-width-dependent switching measurements. The calculation of switching current density ( $J_{\text{SOT}}$ ) is performed with various pulse width ( $t_{\text{pulse}}$ ) followed by 5 ns relaxation. Therefore, the intrinsic SOT critical switching current density ( $J_{\text{SOT},c}$ ) and the precession time ( $\tau_0$ ) can be extracted depending on the formula [12]

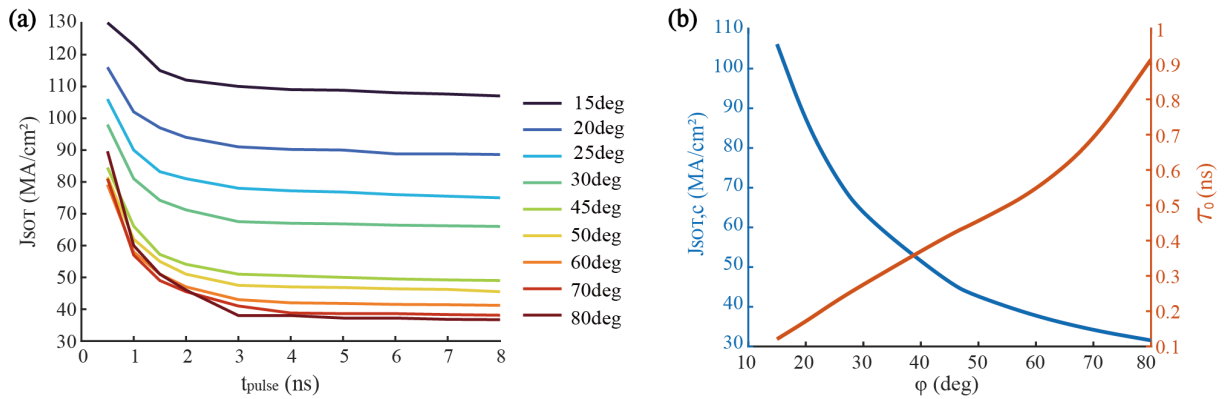
$$J_{\text{SOT}} = J_{\text{SOT},c} \left( 1 + \frac{\tau_0}{t_{\text{pulse}}} \right), \quad (\text{D1})$$

Figure D1(a) shows  $J_{\text{SOT}}$  as a function of  $\varphi$  in the range of  $15 \sim 80$  deg with various  $t_{\text{pulse}}$  up to 8 ns. As  $\varphi$  increases, the SOT-driven switching dynamics transitions from an instability-dominated to a precession-dominated regime. In the long-pulse regime ( $t_{\text{pulse}} > 1$  ns),  $J_{\text{SOT}}$  decreases monotonically with increasing  $\varphi$  and eventually saturates, consistent with the prior report [13]. Notably, smaller  $\varphi$  values demonstrate a more gradual reduction of  $J_{\text{SOT}}$  with  $t_{\text{pulse}}$ , while larger  $\varphi$  display an accelerated decrease in current density. Therefore,  $J_{\text{SOT}}$  with  $\varphi = 80$  deg is even larger than that with  $\varphi = 45$  deg in the case of short-pulse ( $t_{\text{pulse}} < 1$  ns). This phenomenon has been reported by experimental work [14] and explained by the competition between the collinear and orthogonal components of spin accumulation [15].

In Type-y devices ( $\varphi = 90$  deg), the initial magnetization is nearly parallel to  $\vec{\sigma}$ . Similarly to the case of  $\varphi = 80$  deg, a minor angular deviation between the initial magnetization and  $\vec{\sigma}$  results in a small but non-zero SOT strength (since SOT is proportional to  $\vec{m} \times (\vec{\sigma} \times \vec{m})$ ). The collinear component dominates at larger  $\varphi$ , promoting precession-driven magnetization switching, whereas the orthogonal component enhances switching speed but necessitates higher  $J_{\text{SOT}}$  at smaller  $\varphi$ .

As shown in Figure D1(b), the slope of  $\tau_0$  at  $\varphi = 80$  deg is steeper than that at smaller canted angles. This indicates that Type-y devices benefit from a longer precession time, which allows  $\vec{m} \times \vec{\sigma}$  to have enough time for enhancement, resulting in a lower intrinsic switching current compared to Type-x devices. Moreover,  $J_{\text{SOT},c}$  and  $\tau_0$  show the opposite trends with  $\varphi$ , intersecting at  $\varphi \sim 40$  deg where both parameters reach relative minima. This intersection represents an experimentally favorable regime for balancing switching efficiency and energy consumption.

In Figure 1(h) of the main text, we obtained the critical SOT switching current density through two methods: general micromagnetic simulation and pulse-width-dependent switching measurement. Both of the two methods show a strong correlation with Eq. (4) after applying a scaling factor of  $k$ . The inset provides magnetization snapshots of the elliptical free layer, initialized with  $m_x \sim +1$ . Upon applying the current, the magnetization precesses along the  $y$ -axis, with the  $x$ -component gradually decreasing. Subsequently, the opposite magnetic domains form at both ends, leading to the fully switching within a short period of time.



**Figure D1** (a) SOT switching current density versus pulse width for different canted angles. (b) The critical switching current density and precession time for different canted angles.

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